

**Search Notes**

Application/Control No.

10/675,026

Examiner

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Applicant(s)/Patent under  
Reexamination

YEN ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	462.01, .08, 375, 435, 487	6/22/2005	DW
382	190,199	6/22/2005	DW
382	209, 183	6/22/2005	DW
283	17, 901	6/22/2005	DW
283	72,93	6/22/2005	DW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search attached	6/22/2005	DW